

MDP9N50F

N-Channel MOSFET 500V, 8.0 A, 0.97Ω

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General Description

The MDP9N50F uses advanced Magnachip's MOSFET Technology, which provides low on-state resistance, high switching performance and excellent quality.

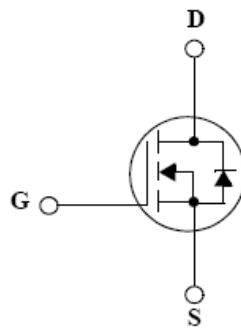
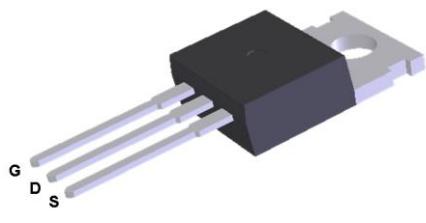
MDP9N50F is suitable device for SMPS, HID and general purpose applications.

Features

- $V_{DS} = 500V$
- $I_D = 8.0A @ V_{GS} = 10V$
- $R_{DS(ON)} \leq 0.97\Omega @ V_{GS} = 10V$

Applications

- Power Supply
- HID
- Lighting



Absolute Maximum Ratings ($T_a = 25^\circ C$)

Characteristics		Symbol	Rating	Unit
Drain-Source Voltage		V_{DSS}	500	V
Gate-Source Voltage		V_{GSS}	± 30	V
Continuous Drain Current	$T_C=25^\circ C$	I_D	8.0	A
	$T_C=100^\circ C$		4.8	A
Pulsed Drain Current ⁽¹⁾		I_{DM}	32	A
Power Dissipation	$T_C=25^\circ C$	P_D	119	W
	Derate above 25 °C		0.95	W/°C
Peak Diode Recovery $dv/dt^{(3)}$		Dv/dt	4.5	V/ns
Single Pulse Avalanche Energy ⁽⁴⁾		E_{AS}	300	mJ
Junction and Storage Temperature Range		T_J, T_{stg}	-55~150	°C

Thermal Characteristics

Characteristics		Symbol	Rating	Unit
Thermal Resistance, Junction-to-Ambient ⁽¹⁾		$R_{\theta JA}$	62.5	°C/W
Thermal Resistance, Junction-to-Case ⁽¹⁾		$R_{\theta JC}$	1.05	

Ordering Information

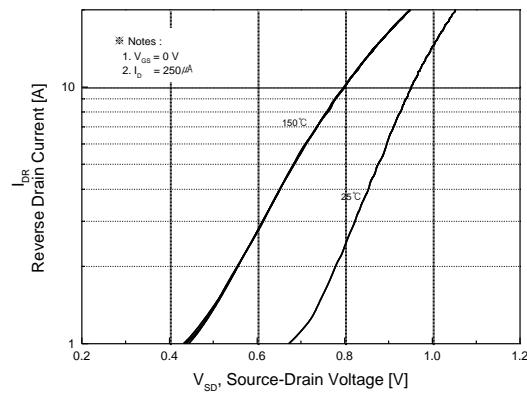
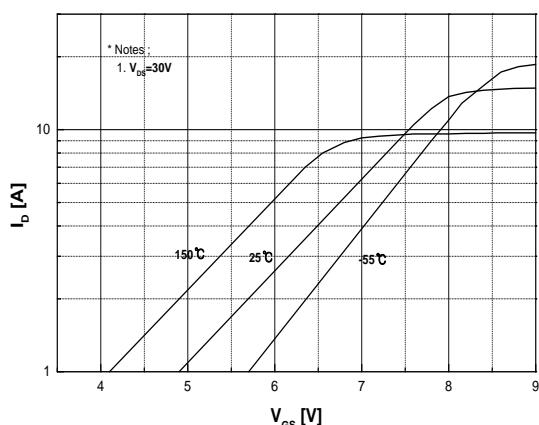
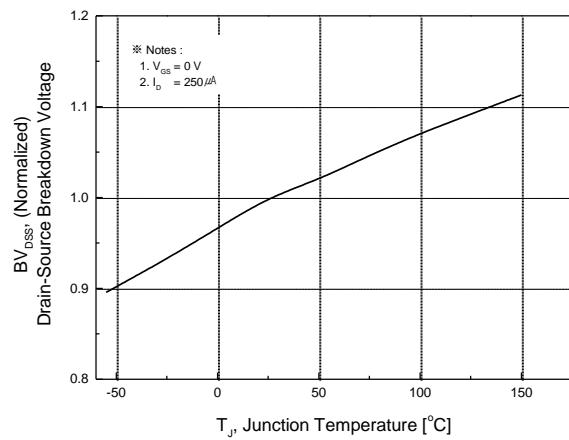
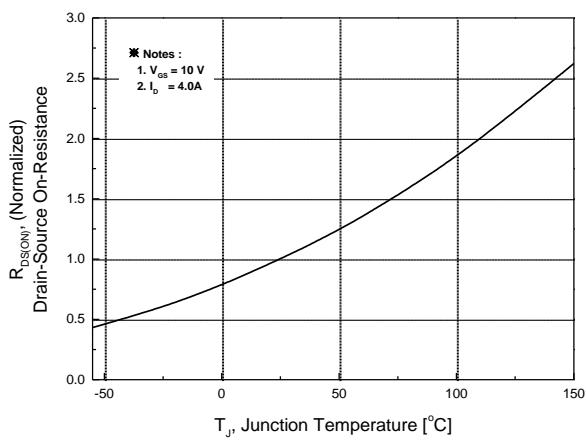
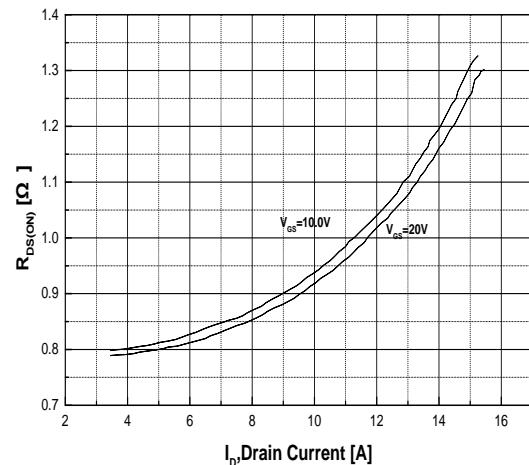
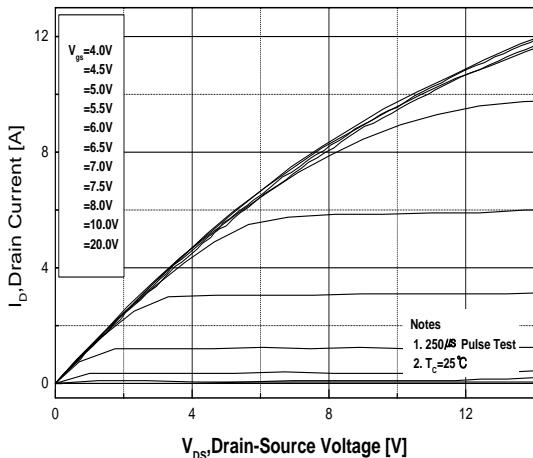
Part Number	Temp. Range	Package	Packing	RoHS Status
MDP9N50FTH	-55~150°C	TO-220	Tube	Halogen Free

Electrical Characteristics ($T_a = 25^\circ\text{C}$)

Characteristics	Symbol	Test Condition	Min	Typ	Max	Unit
Static Characteristics						
Drain-Source Breakdown Voltage	BV_{DSS}	$I_D = 250\mu\text{A}, V_{GS} = 0\text{V}$	500	-	-	V
Gate Threshold Voltage	$V_{GS(\text{th})}$	$V_{DS} = V_{GS}, I_D = 250\mu\text{A}$	2.5	-	4.5	V
Drain Cut-Off Current	I_{DSS}	$V_{DS} = 500\text{V}, V_{GS} = 0\text{V}$	-	-	10	μA
Gate Leakage Current	I_{GSS}	$V_{GS} = \pm 30\text{V}, V_{DS} = 0\text{V}$	-	-	100	nA
Drain-Source ON Resistance	$R_{DS(\text{ON})}$	$V_{GS} = 10\text{V}, I_D = 4.0\text{A}$		0.75	0.97	Ω
Forward Transconductance	g_{fs}	$V_{DS} = 30\text{V}, I_D = 4.0\text{A}$	-	4.2	-	S
Dynamic Characteristics						
Total Gate Charge	Q_g	$V_{DS} = 400\text{V}, I_D = 8.0\text{ A}, V_{GS} = 10\text{V}^{(3)}$	-	16.3	-	nC
Gate-Source Charge	Q_{gs}		-	5.8	-	
Gate-Drain Charge	Q_{gd}		-	6.1	-	
Input Capacitance	C_{iss}	$V_{DS} = 25\text{V}, V_{GS} = 0\text{V}, f = 1.0\text{MHz}$	-	781	-	pF
Reverse Transfer Capacitance	C_{rss}		-	1.83	-	
Output Capacitance	C_{oss}		-	96.1	-	
Turn-On Delay Time	$t_{d(on)}$	$V_{GS} = 10\text{V}, V_{DS} = 250\text{V}, I_D = 8.0\text{A}, R_G = 25\Omega^{(3)}$	-	20.0	-	ns
Rise Time	t_r		-	47.5	-	
Turn-Off Delay Time	$t_{d(off)}$		-	28.0	-	
Fall Time	t_f		-	24.0	-	
Drain-Source Body Diode Characteristics						
Maximum Continuous Drain to Source Diode Forward Current	I_S		-	8.0	-	A
Source-Drain Diode Forward Voltage	V_{SD}	$I_S = 8.0\text{A}, V_{GS} = 0\text{V}$	-	-	1.4	V
Body Diode Reverse Recovery Time	t_{rr}	$I_F = 8.0\text{A}, dI/dt = 100\text{A}/\mu\text{s}^{(3)}$	-	94.5	-	ns
Body Diode Reverse Recovery Charge	Q_{rr}		-	0.24	-	μC

Note :

1. Pulse width is based on R_{EJC} & R_{EJA} and the maximum allowed junction temperature of 150°C .
2. Pulse test: pulse width $\leq 300\mu\text{s}$, duty cycles $\leq 2\%$, pulse width limited by junction temperature $T_{J(\text{MAX})}=150^\circ\text{C}$.
3. $I_{SD} \leq 8.0\text{A}$, $dI/dt \leq 200\text{A}/\mu\text{s}$, $V_{DD}=50\text{V}$, $R_g=25\Omega$, Starting $T_J=25^\circ\text{C}$
4. $L=6.5\text{mH}$, $I_{AS}=8.0\text{A}$, $V_{DD}=50\text{V}$, $R_g=25\Omega$, Starting $T_J=25^\circ\text{C}$



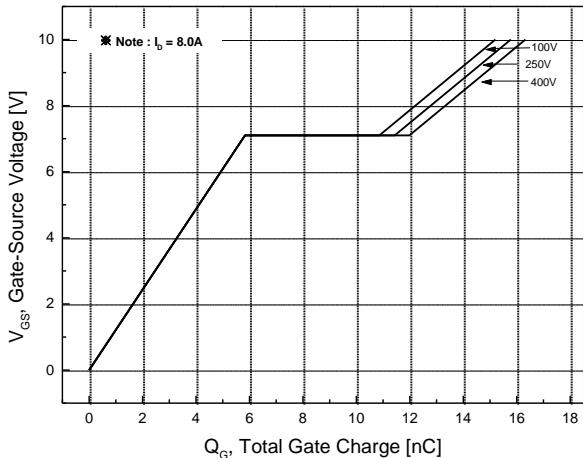


Fig.7 Gate Charge Characteristics

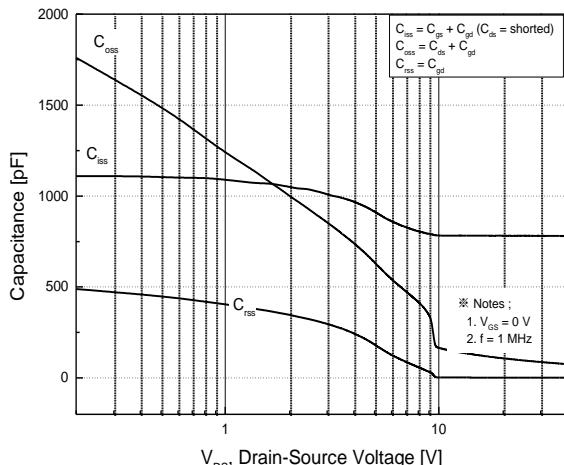


Fig.8 Capacitance Characteristics

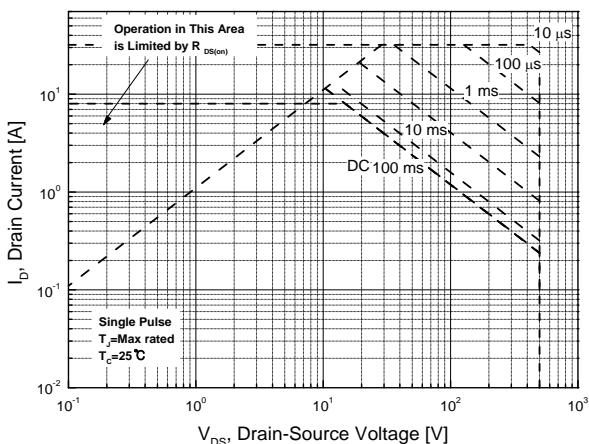


Fig.9 Maximum Safe Operating Area

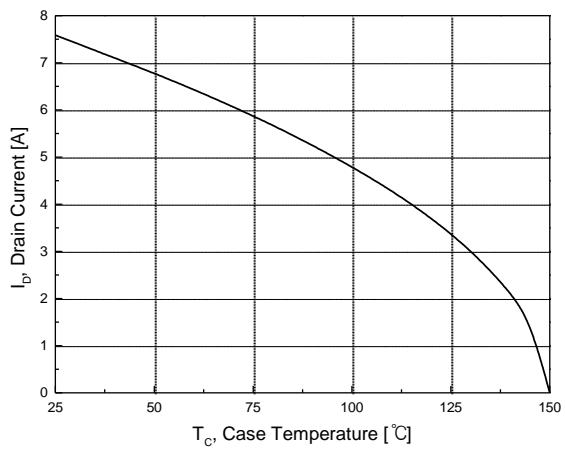


Fig.10 Maximum Drain Current vs. Case Temperature

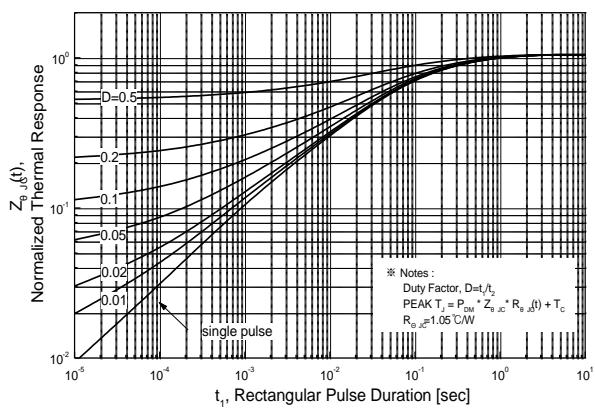


Fig.11 Transient Thermal Response Curve

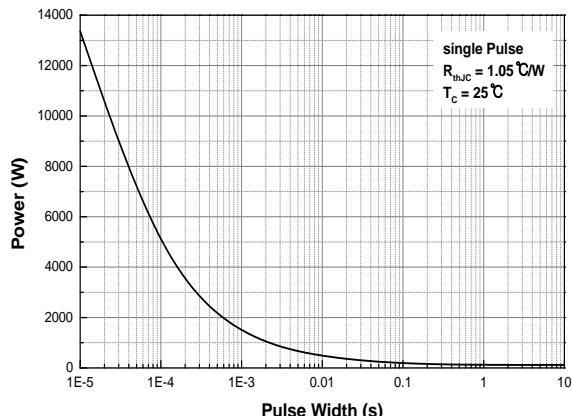
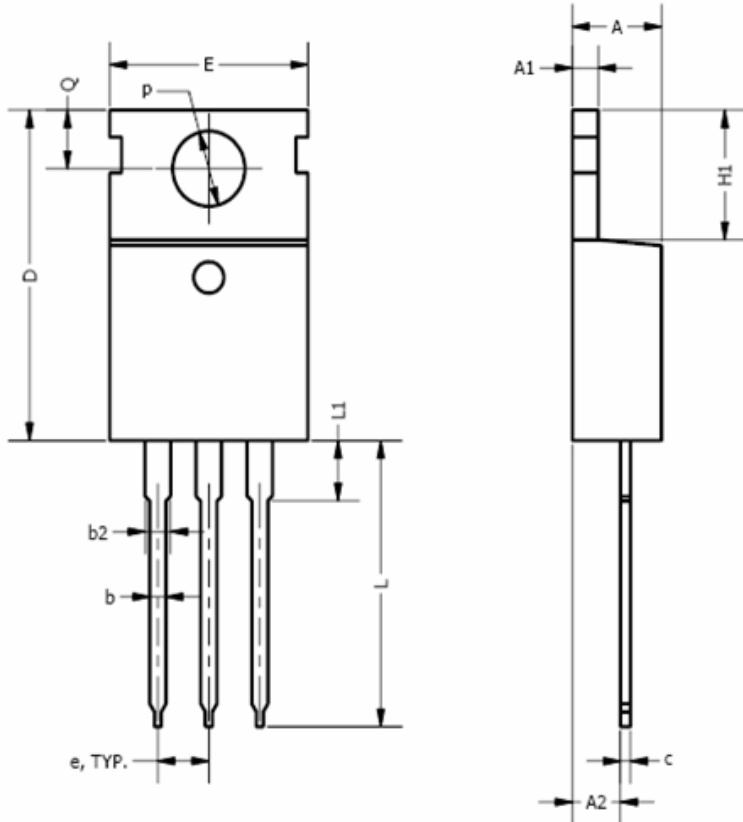


Fig.12 Single Pulse Maximum Power Dissipation

Physical Dimensions

3 Leads, TO-220

Dimensions are in millimeters unless otherwise specified



Symbol	Min	Nom	Max
A	3.56		4.83
A1	0.50		1.40
A2	2.03		2.92
b	0.38	0.69	1.02
b2	1.14	1.45	1.78
c	0.36		0.61
D	14.22		16.51
e	2.54 TYP		
E	9.65		10.67
H1	5.84		6.86
L	12.70		14.73
L1			6.35
ΦP	3.53		4.09
Q	2.54		3.43

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